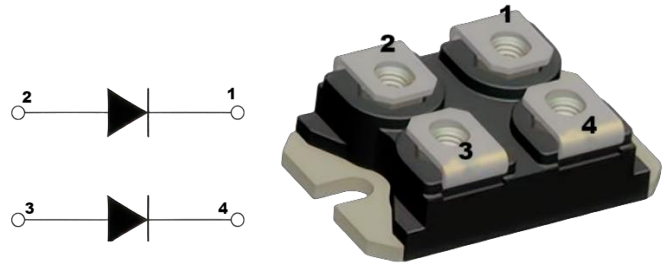


SiC Schottky Diode Module

Parameter	Value	Unit
V_{RRM}	1700	V
I_F	80	A



Features

- SiC Schottky Diode
- High Blocking Voltage, $V_{BR}=1700V$
- $175^{\circ}C$ maximum junction temperature
- Fast, temperature-independent switching
- Positive Temperature Coefficient on VF

Applications

- Motor drives
- Solar/ Wind inverters
- Boost diode in PFC
- UPS applications
- EV and DC fast charging
- Induction heating and welding

Module Type

Parameter	Condition	Value	Unit
Isolation Voltage	RMS, $f=50Hz$, $t=1s$	3.0	kV
Material of module baseplate	-	Cu	-
Creepage distance	terminal to heatsink terminal to terminal	114.5 13	mm
Clearance	terminal to heatsink terminal to terminal	8 7	mm
CTI	-	>400	-
Mounting torque for module mounting	M4	1.1 to 1.5	Nm
Weight	-	30	g

Maximum Ratings

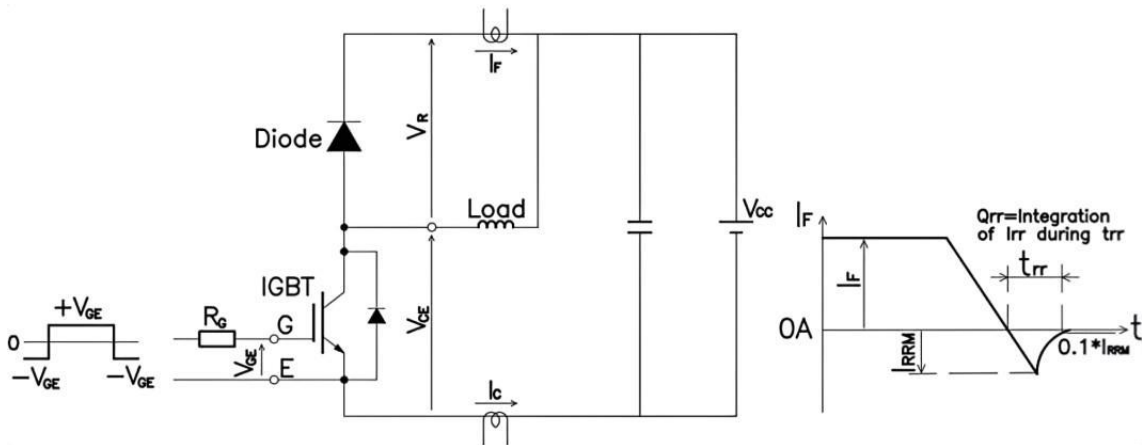
Symbol	Parameter	Condition	Ratings	Unit
V_{RRM}	Repetitive peak reverse voltage	$T_j=25^{\circ}C$	1700	V
I_F	Forward Current per diode	$T_c=100^{\circ}C$	80	A
I_{FSM}	Pulse Forward Current per diode	$t_p=10\text{ ms}$, Half Sine Pulse, Note1	740	A
$I_{F,max}$	Repetitive peak forward current	$t_p=10\text{ ms}$, $f=0.1Hz$, 100 cycles, Half Sine Pulse	580	A
T_j	junction temperature	-	-55 to 175	$^{\circ}C$
T_{stg}	Storage temperature	-	-55 to 175	$^{\circ}C$

Note1: Pulse width limited by maximum junction temperature

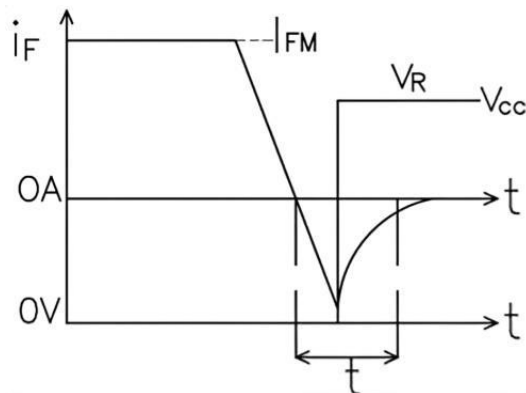
Electrical Characteristics

Symbol	Item	Condition	Value			Unit	
			Min.	Typ.	Max.		
V_{DC}	DC blocking Voltage	$T_j = 25^\circ\text{C}$	1700	-	-	V	
V_F	Diode forward Voltage	$I_F = 80\text{A}$	$T_j = 25^\circ\text{C}$	-	1.45	1.75	V
			$T_j = 125^\circ\text{C}$	-	1.9	-	
			$T_j = 175^\circ\text{C}$	-	2.3	-	
I_R	Reverse Current	$V_R = 1700\text{V}$	$T_j = 25^\circ\text{C}$	-	8	600	μA
			$T_j = 125^\circ\text{C}$	-	48	-	
			$T_j = 175^\circ\text{C}$	-	200	-	
Q_C	Total capacitive charge	$V_R = 1700\text{V}$	$T_j = 25^\circ\text{C}$	-	808	-	nC
C	Total capacitance	$V_R = 800\text{V}, f = 1\text{MHz}$	$T_j = 25^\circ\text{C}$	-	356	-	pF
		$V_R = 1200\text{V}, f = 1\text{MHz}$	$T_j = 25^\circ\text{C}$	-	332	-	
		$V_R = 1700\text{V}, f = 1\text{MHz}$	$T_j = 25^\circ\text{C}$	-	316	-	
$R_{th(j-c)}$	SiC SBD Thermal Resistance	Junction to Case	-	TBD	-	K/W	

Test Conditions



Q_{rr} / t_{rr} test circuit and waveform



Reverse recovery energy test waveform

Characteristics Diagrams

Fig1. IF vs VF

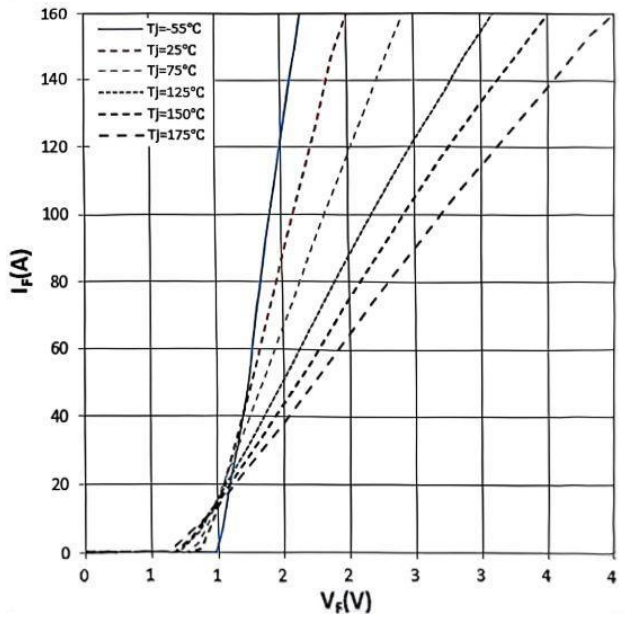
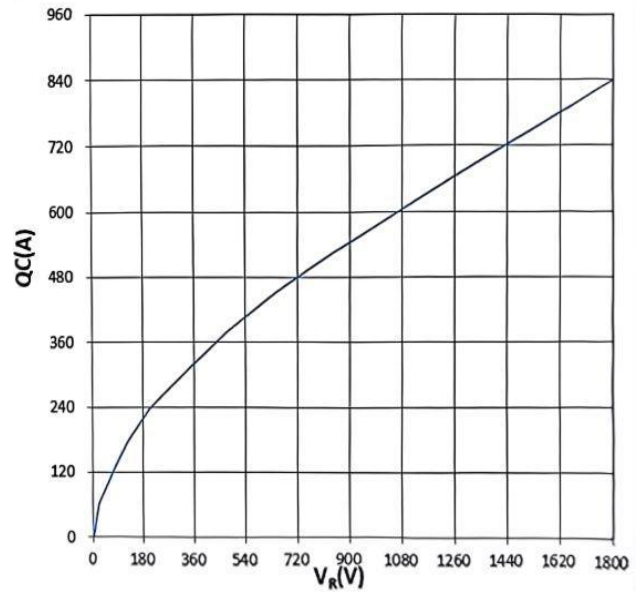
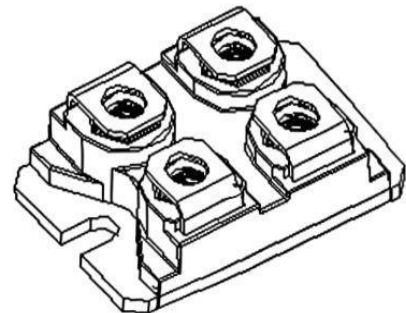
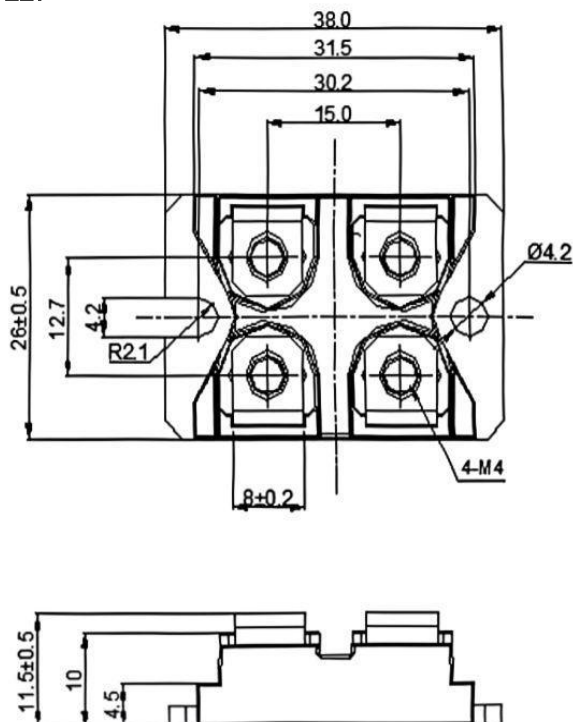


Fig2. QC vs VR, $T_J = 25^\circ\text{C}$



Package Outlines

SOT-227



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